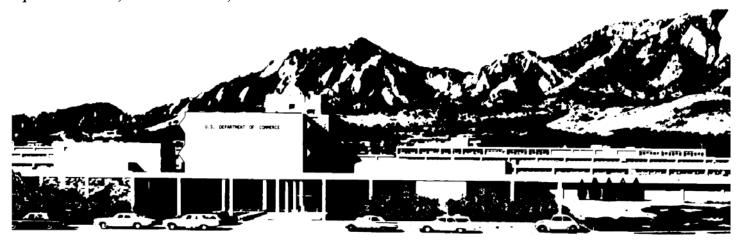
SOFM 2006 PROGRAM

A NIST symposium for photonic and fiber measurements September 19-20, 2006 – Boulder, Colorado



Tuesday, September 19, 2006

8:30 **Opening Remarks:** Paul Williams, NIST, Symposium Co-Chair

Session I. Fiber Sensors, Chair: Gordon Day, NIST

- 8:45 INVITED: Photonic Sensor Market Evolution, Opportunities and Metrology Needs, David Krohn, Light Wave Venture LLC
- 9:15 Modulation Function Study of Coupling Based Intensity Modulated Fiber-Optic Sensors, Johan Jason^{1,2}, Hans-Erik Nilsson¹, Bertil Arvidsson^{1,3}, Anders Larsson², ¹Department of Information Technology and Media, Mid-Sweden University, ²Fiberson AB, ³Ericsson Network Technologies AB
- 9:30 Characteristics of Spun Fiber Grating Sensors, Yong Wang and Chang-Qing Xu, *Department of Engineering Physics*, *McMaster University*, *Canada*
- 9:45 Metrology of Integrated Waveguide Devices and Systems Using Near-Field Scanning Optical Microscopy, Guangwei Yuan and Kevin L. Lear, *Electrical and Computer Engineering Department, Colorado State University*
- 10:00 **BREAK**

Session II. Power-Related Metrology, Chair: Alan McCurdy, OFS

- 10:30 Return Loss Measurement in the Presence of Variable Insertion Loss Using Optical Frequency Domain Reflectometry, Stephen Kreger, Mark Froggatt, Dawn Gifford, Matthew Wolfe, and Brian Soller, *Luna Technologies*
- 10:45 High-Power Nonlinearity of Optical Fiber Power Meters for Pump Lasers at 980 and 1480 nm, I. Vayshenker and S. Yang, *NIST*, R. Swafford, *OZ Optics Ltd*.
- 11:00 Novel Approach for Non-Intrusive "Clip-On" Fiber Monitoring, Gang He, Daniel Gariépy, Hongxin Chen, Jean Théberge, and Gregory W. Schinn, *EXFO Electro-Optical Engineering, Inc.*
- 11:15 Measurement Technique for Stimulated Brillouin Scattering Threshold, Per Olof Hedekvist and Anne Andersson, *SP*, *Swedish National Testing and Research Institute*
- 11:30 Butt-Joint Splice with Refractive Index Matching Material for High Power Light in Optical Fiber Communications, Ikutaro Ogushi, Hisashi Izumita, Kuniaki Tanaka, Fumihiko Ito, and Masahito Arii, NTT Access Network Service Systems Laboratories, NTT Corp., Japan
- 11:45 High Speed PRBS for Detection of Defects in Fibers and Fiber Connectors, S. Rangaswamy, D. Lao, and E. van Doorn, *Intelligent Automation Inc.*
- 12:00 Experimental Investigation on Special Shaped Fibers Coupling with InP-Based Planar Lightwave Circuit Chips, Xu Liu, Jinbiao Xiao, Xiaohan Sun, *Department of Electronic Engineering, Southeast University, P.R. China*
- 12:15 LUNCH

Session III. Spectroscopic and Frequency Metrology, Chair: Janet Jackel, Telcordia

- 1:45 **INVITED:** Fiber Frequency Combs: Development and Applications, N. R. Newbury, W. C. Swann, I. Coddington, and J. J. McFerran, *NIST*
- 2:15 Generation of a Frequency Comb by FWM in SOAs Enhanced by Raman, Ana Carrasco-Sanz^a, Sonia Martín-López^a, Miguel González-Herráez^{a,b}, Pedro Corredera^a, Maria Luisa Hernanz^a and Laura Abrardi^a, **Departamento de Metrología, Instituto de Física Aplicada, (CSIC) Madrid, **Departamento de Electrónica, Universidad de Alcalá, Spain
- 2: 30 Comparison of Saturated Absorption Spectra of Acetylene Gas Inside Photonic Bandgap Fibers, K. Knabe, R. Thapa, O. L. Weaver, B. R. Washburn, and K. L. Corwin, *Dept. of Physics, Kansas State University*
- 2:45 CW Supercontinuum Generation in Standard Optical Fiber over the O, E, S and C Communication Bands, Laura Abrardi^a, Sonia Martín-López^a, Ana Carrasco-Sanz^a, Miguel González-Herráez ^{a,b}, Pedro Corredera^a and Maria Luisa Hernanz^a, ^aDepartamento de Metrología, Instituto de Física Aplicada, (CSIC), Madrid, ^bDepartamento de Electrónica, Universidad de Alcalá, Spain
- 3:00 A C-Band Optical Frequency Synthesizer Using 1.5 Micron NICE OHMS Frequency Standards and an Optical Frequency Comb Generator, C. S. Edwards^{1,2}, H.S. Margolis¹, G.P. Barwood¹, P. Gill^{1,2}, and W.R.C. Rowley¹, ¹National Physical Laboratory, ²Blackett Laboratory, Imperial College, UK
- 3:15 **BREAK**

Session IV. Dispersion Metrology, Chair: Greg Schinn, EXFO

- 3:45 **INVITED:** PMD: Measurement Method Linkages, T.A. Hanson, *Corning Inc.*
- 4:15 PMD Measurements Using Fixed-Analyzer Technique on a 1000km Amplified Link that Includes ROADMs, Vincent Lecoeuche¹, Fabien Sauron¹ and André Champavère¹, Alexey Turukhin² and Enrico Gonzales², ¹JDSU Commtest Division, ²JDSU Optical Network Research
- 4:30 Chromatic Dispersion Measurement Technique Utilizing an Unstable Supercontinuum Pulse Source, Sucbei Moon and Dug Y. Kim, *Gwangju Institute of Science Technology (GIST), Republic of Korea*
- 4:45 Accurate Measurement of Chromatic Dispersion Distribution along Dispersion Managed Transmission System, Mirza Imran Baig, Tohru Miyauchi and Masaaki Imai, *Dept. of Electrical & Electronic Engineering, Muroran Institute of Technology, Japan*
- 5:00 Assessment of the Potential Accuracy of a Four Wavelength OTDR to Measure Chromatic Dispersion, David Ives, Joan Hall and Christian Hart, *National Physical Laboratory, UK*
- 5:15 SESSION CLOSE
- 6:30 CONFERENCE RECEPTION / DINNER RED LION INN

Wednesday, September 20, 2006

Session V. Tutorial – FTTx Measurement Issues, Chair: André Champavère, JDSU

- 8:30 **INVITED**: Critical Issues Relating to FTTH/PON Testing, Andre Girard, *EXFO E.O. Engineering, Inc.*
- 9:00 **INVITED**: WDM-PON for FTTx, Wayne V. Sorin¹, Chang-Hee Lee², Byoung Y. Kim¹, ¹Novera Optics, Inc., ²Korea Advanced Institute of Science and Technology
- 9: 30 **INVITED**: FTTx Deployment Issues, Jimmy Salinas, AT&T
- 10:00 **BREAK**

Session VI. Specialty Fibers, Chair: Tom Hanson, Corning Inc.

- 10:30 **INVITED**: Special Requirements for Measurement Techniques Used for POF and Thick Glass Fibers, Olaf Ziemann, *Polymer Optical Fiber Application Center, University of Applied Sciences Nürnberg, Germany*
- 11:00 **INVITED**: Characterization of Hole-Assisted Fibers as Single Polarization Fibers and Polarization Maintaining Fibers, Xin Chen, Joohyun Koh, Ming-Jun Li, and Daniel A. Nolan, *Corning Inc.*
- 11:30 Micro-Tomographic Reconstruction for Arbitrary Refractive Index Profiling of Optical Fibers, N.M. Dragomir¹, X. M. Goh¹, G. Baxter² and A. Roberts¹, ¹School of Physics, The University of Melbourne, ²School of Electrical Engineering, Victoria University of Technology, Australia
- 11:45 Fictive Temperature Distribution in Highly Ge-Doped Multimode Optical Fibers, M. Lancry¹, I. Flammer², D. Simons³, B. Poumellec¹, C. Depecker⁴, P. Nouchi² and M. Douay⁵, ¹ICMMO/LPCES, Université Paris Sud (XI), ²Draka Comteq France, ³Draka Comteq Fiber BV, Netherlands, ⁴LSPES, Université des Sciences et Technologies de Lille, France, ⁵PhLAM, Université des Sciences et Technologies de Lille, France
- 12:00 LUNCH

Session VII. Systems Metrology, Chair: Dug Young Kim, GIST

- 1:30 **INVITED:** Monitoring OSNR in Dynamic WDM Network, Y. C. Chung, *Korea Advanced Institute of Science and Technology, Department of Electrical Engineering and Computer Science*
- 2:00 Optical Signal Quality Monitoring Based on Asynchronous Amplitude Histogram for DPSK Systems, H. Takara¹, T. Ohara¹, and B. Kozicki², ¹NTT Network Innovation Laboratories, NTT Corp., ²Osaka University, Japan
- 2:15 **INVITED**: New Methods for Investigating Mode Coupling in Multimode Fiber: Impact on High-Speed Links and Channel Equalization, Stephen E. Ralph, Arup Polley, *Georgia Institute of Technology*, K. D. Pedrotti, R. P. Dahlgren, J. A. Wysocki, *Dept. of Electrical Engineering, University of California, Santa Cruz*
- 2:45 A Differential Mode Delay Measurement for a Multimode Optical Fiber with Fourier-Domain Low-Coherence Interferometry, J.Y. Lee, T-J. Ahn, and D.Y. Kim, *Department of Information and Communications, Gwangju Institute of Science and Technology, Republic of Korea*
- 3:00 **BREAK**

Session VIII. Workshop

3:30 – 5:00 Fiber and Photonic Metrology Roadmapping

5:00 **SYMPOSIUM CLOSE**

SYMPOSIUM COMMITTEE

P.A. Williams, NIST, Co-Chair, T.J. Drapela, NIST, Co-Chair

A. Barlow, *PerkinElmer*A. Champavère, *JDSU*G.W. Day, *NIST*S.C. Fleming, *Univ*, *of Sydney*D. Franzen, *NIST*

N. Gisin, Univ. of Geneva

M. Hackert, *U.S. Navy*T.A. Hanson, *Corning*D. Humphreys, *NPL*J. Jackel, *Telcordia*D.Y. Kim, *GIST*

P. Kolesar, SYSTIMAX Solutions

D. Krohn, Light Wave Venture

G. Kuyt, Draka Comteq

A. McCurdy, OFS

G. W. Schinn, EXFO

C. Shaar, Photon Kinetics

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